S	} e	a	rc	:h	N	0	te	S



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/816,540	LAU ET AL.	
Examiner	Art Unit	
Binh V. Ho	2163	

			
SEARCHED			
Class	Subclass	Date	Examiner
707	1	3/28/2007	вн
			-
		-	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
· · ·			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
707/1,8,201,10,2 East search (see printout)	3/28/2007	вн
×		
		·
-		
<u> </u>		